Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/671,326	WANG ET AL.	
Examiner	Art Unit	
Nyeemah Grazier	1626	

SEARCHED					
Class	Subclass	Date	Examiner		
544	137	6/20/2005	NG		
514	231.8	6/20/2005			
548	229	6/20/2005			
514	376	6/20/2005			
546	256	6/20/2005			
514	336	6/20/2005	NO		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN (Online) structure search	6/17/2005	No		
Classification	6/20/2005			
Inventor Name Search	6/21/2005			
IDS	6/21/2005	M		